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## Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

## Details

Product Status	Obsolete
Core Processor	C166SV2
Core Size	16-Bit
Speed	80MHz
Connectivity	EBI/EMI, I <sup>2</sup> C, LINbus, SPI, SSC, UART/USART, USI
Peripherals	I <sup>2</sup> S, POR, PWM, WDT
Number of I/O	119
Program Memory Size	384KB (384K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	34K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 16x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP Exposed Pad
Supplier Device Package	PG-LQFP-144-4
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/saf-xe167km-48f80l-aa

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Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



## 16-Bit

Architecture

# XE167FM, XE167GM, XE167HM, XE167KM

16-Bit Single-Chip Real Time Signal Controller XE166 Family / Base Line

Data Sheet V2.1 2011-07

## Microcontrollers



Table	Fable 5         Pin Definitions and Functions (cont'd)					
Pin	Symbol	Ctrl.	Туре	Function		
69	P2.6	O0 / I	St/B	Bit 6 of Port 2, General Purpose Input/Output		
	U0C0_SELO 0	01	St/B	USIC0 Channel 0 Select/Control 0 Output		
	U0C1_SELO 1	O2	St/B	USIC0 Channel 1 Select/Control 1 Output		
	CC2_CC19	O3 / I	St/B	CAPCOM2 CC19IO Capture Inp./ Compare Out.		
	A19	OH	St/B	External Bus Interface Address Line 19		
	U0C0_DX2D	I	St/B	USIC0 Channel 0 Shift Control Input		
	RxDC0D	I	St/B	CAN Node 0 Receive Data Input		
	ESR2_6	I	St/B	ESR2 Trigger Input 6		
70	P4.4	O0 / I	St/B	Bit 4 of Port 4, General Purpose Input/Output		
	U3C0_SELO 2	01	St/B	USIC3 Channel 0 Select/Control 2 Output		
	CC2_CC28	O3 / I	St/B	CAPCOM2 CC28IO Capture Inp./ Compare Out.		
	CS4	OH	St/B	External Bus Interface Chip Select 4 Output		
	CLKIN2	I	St/B	Clock Signal Input 2		
	U3C0_DX2C	I	St/B	USIC3 Channel 0 Shift Control Input		
71	P4.3	O0 / I	St/B	Bit 3 of Port 4, General Purpose Input/Output		
	U0C1_DOUT	01	St/B	USIC0 Channel 1 Shift Data Output		
	CC2_CC27	O3 / I	St/B	CAPCOM2 CC27IO Capture Inp./ Compare Out.		
	CS3	OH	St/B	External Bus Interface Chip Select 3 Output		
	RxDC2A	I	St/B	CAN Node 2 Receive Data Input		
	T2EUDA	I	St/B	GPT12E Timer T2 External Up/Down Control Input		
	CCU62_CCP OS2B	I	St/B	CCU62 Position Input 2		



Table	Fin Definitions and Functions (cont'd)					
Pin	Symbol	Ctrl.	Туре	Function		
101	P3.5	O0 / I	St/B	Bit 5 of Port 3, General Purpose Input/Output		
	U2C1_SCLK OUT	O1	St/B	USIC2 Channel 1 Shift Clock Output		
	U2C0_SELO 2	O2	St/B	USIC2 Channel 0 Select/Control 2 Output		
	U0C0_SELO 5	O3	St/B	USIC0 Channel 0 Select/Control 5 Output		
	U2C1_DX1A	I	St/B	USIC2 Channel 1 Shift Clock Input		
102	P0.6	O0 / I	St/B	Bit 6 of Port 0, General Purpose Input/Output		
	U1C1_DOUT	01	St/B	USIC1 Channel 1 Shift Data Output		
	TxDC1	02	St/B	CAN Node 1 Transmit Data Output		
	CCU61_COU T63	O3	St/B	CCU61 Channel 3 Output		
	A6	ОН	St/B	External Bus Interface Address Line 6		
	U1C1_DX0A	I	St/B	USIC1 Channel 1 Shift Data Input		
	CCU61_CTR APA	I	St/B	CCU61 Emergency Trap Input		
	U1C1_DX1B	I	St/B	USIC1 Channel 1 Shift Clock Input		
103	P10.6	O0 / I	St/B	Bit 6 of Port 10, General Purpose Input/Output		
	U0C0_DOUT	01	St/B	USIC0 Channel 0 Shift Data Output		
	TxDC4	02	St/B	CAN Node 4 Transmit Data Output		
	U1C0_SELO 0	O3	St/B	USIC1 Channel 0 Select/Control 0 Output		
	AD6	OH / IH	St/B	External Bus Interface Address/Data Line 6		
	U0C0_DX0C	I	St/B	USIC0 Channel 0 Shift Data Input		
	U1C0_DX2D	I	St/B	USIC1 Channel 0 Shift Control Input		
	CCU60_CTR APA	1	St/B	CCU60 Emergency Trap Input		



Table	Table 5         Pin Definitions and Functions (cont'd)				
Pin	Symbol	Ctrl.	Туре	Function	
107	P3.7	O0 / I	St/B	Bit 7 of Port 3, General Purpose Input/Output	
	U2C1_DOUT	O1	St/B	USIC2 Channel 1 Shift Data Output	
	U2C0_SELO 3	O2	St/B	USIC2 Channel 0 Select/Control 3 Output	
	U0C0_SELO 7	O3	St/B	USIC0 Channel 0 Select/Control 7 Output	
	U2C1_DX0B	I	St/B	USIC2 Channel 1 Shift Data Input	
111	P1.0	O0 / I	St/B	Bit 0 of Port 1, General Purpose Input/Output	
	U1C0_MCLK OUT	O1	St/B	USIC1 Channel 0 Master Clock Output	
	U1C0_SELO 4	O2	St/B	USIC1 Channel 0 Select/Control 4 Output	
	A8	ОН	St/B	External Bus Interface Address Line 8	
	ESR1_3	I	St/B	ESR1 Trigger Input 3	
	CCU62_CTR APB	1	St/B	CCU62 Emergency Trap Input	
	T6INB	I	St/B	GPT12E Timer T6 Count/Gate Input	
112	P9.0	O0 / I	St/B	Bit 0 of Port 9, General Purpose Input/Output	
	CCU63_CC6 0	O1	St/B	CCU63 Channel 0 Output	
	CCU63_CC6 0INA	1	St/B	CCU63 Channel 0 Input	
	T6EUDB	I	St/B	GPT12E Timer T6 External Up/Down Control Input	



Table	Table 5         Pin Definitions and Functions (cont'd)					
Pin	Symbol	Ctrl.	Туре	Function		
115	P10.9	O0 / I	St/B	Bit 9 of Port 10, General Purpose Input/Output		
	U0C0_SELO 4	01	St/B	USIC0 Channel 0 Select/Control 4 Output		
	U0C1_MCLK OUT	02	St/B	USIC0 Channel 1 Master Clock Output		
	AD9	OH / IH	St/B	External Bus Interface Address/Data Line 9		
	CCU60_CCP OS2A	I	St/B	CCU60 Position Input 2		
	TCK_B	IH	St/B	<b>DAP0/JTAG Clock Input</b> If JTAG pos. B is selected during start-up, an internal pull-up device will hold this pin high when nothing is driving it. If DAP pos. 1 is selected during start-up, an internal pull-down device will hold this pin low when nothing is driving it.		
	T3INB	I	St/B	GPT12E Timer T3 Count/Gate Input		
116	P1.1	O0 / I	St/B	Bit 1 of Port 1, General Purpose Input/Output		
	CCU62_COU T62	01	St/B	CCU62 Channel 2 Output		
	U1C0_SELO 5	02	St/B	USIC1 Channel 0 Select/Control 5 Output		
	U2C1_DOUT	O3	St/B	USIC2 Channel 1 Shift Data Output		
	A9	ОН	St/B	External Bus Interface Address Line 9		
	ESR2_3	I	St/B	ESR2 Trigger Input 3		
	U2C1_DX0C	1	St/B	USIC2 Channel 1 Shift Data Input		



With this hardware most XE167xM instructions are executed in a single machine cycle of 12.5 ns with an 80-MHz CPU clock. For example, shift and rotate instructions are always processed during one machine cycle, no matter how many bits are shifted. Also, multiplication and most MAC instructions execute in one cycle. All multiple-cycle instructions have been optimized so that they can be executed very fast; for example, a 32-/16-bit division is started within 4 cycles while the remaining cycles are executed in the background. Another pipeline optimization, the branch target prediction, eliminates the execution time of branch instructions if the prediction was correct.

The CPU has a register context consisting of up to three register banks with 16 wordwide GPRs each at its disposal. One of these register banks is physically allocated within the on-chip DPRAM area. A Context Pointer (CP) register determines the base address of the active register bank accessed by the CPU at any time. The number of these register bank copies is only restricted by the available internal RAM space. For easy parameter passing, a register bank may overlap others.

A system stack of up to 32 Kwords is provided for storage of temporary data. The system stack can be allocated to any location within the address space (preferably in the on-chip RAM area); it is accessed by the CPU with the stack pointer (SP) register. Two separate SFRs, STKOV and STKUN, are implicitly compared with the stack pointer value during each stack access to detect stack overflow or underflow.

The high performance of the CPU hardware implementation can be best utilized by the programmer with the highly efficient XE167xM instruction set. This includes the following instruction classes:

- Standard Arithmetic Instructions
- DSP-Oriented Arithmetic Instructions
- Logical Instructions
- Boolean Bit Manipulation Instructions
- Compare and Loop Control Instructions
- Shift and Rotate Instructions
- Prioritize Instruction
- Data Movement Instructions
- System Stack Instructions
- Jump and Call Instructions
- Return Instructions
- System Control Instructions
- Miscellaneous Instructions

The basic instruction length is either 2 or 4 bytes. Possible operand types are bits, bytes and words. A variety of direct, indirect or immediate addressing modes are provided to specify the required operands.



## 3.8 Capture/Compare Unit (CAPCOM2)

The CAPCOM2 unit supports generation and control of timing sequences on up to 16 channels with a maximum resolution of one system clock cycle (eight cycles in staggered mode). The CAPCOM2 unit is typically used to handle high-speed I/O tasks such as pulse and waveform generation, pulse width modulation (PWM), digital to analog (D/A) conversion, software timing, or time recording with respect to external events.

Two 16-bit timers (T7/T8) with reload registers provide two independent time bases for the capture/compare register array.

The input clock for the timers is programmable to several prescaled values of the internal system clock, or may be derived from an overflow/underflow of timer T6 in module GPT2. This provides a wide range or variation for the timer period and resolution and allows precise adjustments to the application-specific requirements. In addition, an external count input allows event scheduling for the capture/compare registers relative to external events.

The capture/compare register array contains 16 dual purpose capture/compare registers, each of which may be individually allocated to either CAPCOM timer and programmed for capture or compare function.

All registers have each one port pin associated with it which serves as an input pin for triggering the capture function, or as an output pin to indicate the occurrence of a compare event.

When a capture/compare register has been selected for capture mode, the current contents of the allocated timer will be latched ('captured') into the capture/compare register in response to an external event at the port pin which is associated with this register. In addition, a specific interrupt request for this capture/compare register is generated. Either a positive, a negative, or both a positive and a negative external signal transition at the pin can be selected as the triggering event.

The contents of all registers which have been selected for one of the five compare modes are continuously compared with the contents of the allocated timers.

When a match occurs between the timer value and the value in a capture/compare register, specific actions will be taken based on the selected compare mode.

Compare Modes	Function
Mode 0	Interrupt-only compare mode; Several compare interrupts per timer period are possible
Mode 1	Pin toggles on each compare match; Several compare events per timer period are possible

Table 8 Compare Modes



## 3.9 Capture/Compare Units CCU6x

The XE167xM types feature the CCU60, CCU61, CCU62 and CCU63 unit(s).

The CCU6 is a high-resolution capture and compare unit with application-specific modes. It provides inputs to start the timers synchronously, an important feature in devices with several CCU6 modules.

The module provides two independent timers (T12, T13), that can be used for PWM generation, especially for AC motor control. Additionally, special control modes for block commutation and multi-phase machines are supported.

## **Timer 12 Features**

- Three capture/compare channels, where each channel can be used either as a capture or as a compare channel.
- Supports generation of a three-phase PWM (six outputs, individual signals for highside and low-side switches)
- 16-bit resolution, maximum count frequency = peripheral clock
- Dead-time control for each channel to avoid short circuits in the power stage
- Concurrent update of the required T12/13 registers
- Center-aligned and edge-aligned PWM can be generated
- Single-shot mode supported
- Many interrupt request sources
- Hysteresis-like control mode
- Automatic start on a HW event (T12HR, for synchronization purposes)

## **Timer 13 Features**

- One independent compare channel with one output
- 16-bit resolution, maximum count frequency = peripheral clock
- Can be synchronized to T12
- Interrupt generation at period match and compare match
- Single-shot mode supported
- Automatic start on a HW event (T13HR, for synchronization purposes)

## **Additional Features**

- Block commutation for brushless DC drives implemented
- Position detection via Hall sensor pattern
- Automatic rotational speed measurement for block commutation
- Integrated error handling
- Fast emergency stop without CPU load via external signal (CTRAP)
- Control modes for multi-channel AC drives
- Output levels can be selected and adapted to the power stage



#### **MultiCAN Features**

- CAN functionality conforming to CAN specification V2.0 B active for each CAN node (compliant to ISO 11898)
- Independent CAN nodes
- Set of independent message objects (shared by the CAN nodes)
- Dedicated control registers for each CAN node
- Data transfer rate up to 1 Mbit/s, individually programmable for each node
- · Flexible and powerful message transfer control and error handling capabilities
- Full-CAN functionality for message objects:
  - Can be assigned to one of the CAN nodes
  - Configurable as transmit or receive objects, or as message buffer FIFO
  - Handle 11-bit or 29-bit identifiers with programmable acceptance mask for filtering
  - Remote Monitoring Mode, and frame counter for monitoring
- Automatic Gateway Mode support
- 16 individually programmable interrupt nodes
- Analyzer mode for CAN bus monitoring

## 3.15 System Timer

The System Timer consists of a programmable prescaler and two concatenated timers (10 bits and 6 bits). Both timers can generate interrupt requests. The clock source can be selected and the timers can also run during power reduction modes.

Therefore, the System Timer enables the software to maintain the current time for scheduling functions or for the implementation of a clock.



## 3.16 Watchdog Timer

The Watchdog Timer is one of the fail-safe mechanisms which have been implemented to prevent the controller from malfunctioning for longer periods of time.

The Watchdog Timer is always enabled after an application reset of the chip. It can be disabled and enabled at any time by executing the instructions DISWDT and ENWDT respectively. The software has to service the Watchdog Timer before it overflows. If this is not the case because of a hardware or software failure, the Watchdog Timer overflows, generating a prewarning interrupt and then a reset request.

The Watchdog Timer is a 16-bit timer clocked with the system clock divided by 16,384 or 256. The Watchdog Timer register is set to a prespecified reload value (stored in WDTREL) in order to allow further variation of the monitored time interval. Each time it is serviced by the application software, the Watchdog Timer is reloaded and the prescaler is cleared.

Time intervals between 3.2  $\mu$ s and 13.42 s can be monitored (@ 80 MHz). The default Watchdog Timer interval after power-up is 6.5 ms (@ 10 MHz).

## 3.17 Clock Generation

The Clock Generation Unit can generate the system clock signal  $f_{SYS}$  for the XE167xM from a number of external or internal clock sources:

- External clock signals with pad voltage or core voltage levels
- External crystal or resonator using the on-chip oscillator
- On-chip clock source for operation without crystal/resonator
- Wake-up clock (ultra-low-power) to further reduce power consumption

The programmable on-chip PLL with multiple prescalers generates a clock signal for maximum system performance from standard crystals, a clock input signal, or from the on-chip clock source. See also **Section 4.6.2**.

The Oscillator Watchdog (OWD) generates an interrupt if the crystal oscillator frequency falls below a certain limit or stops completely. In this case, the system can be supplied with an emergency clock to enable operation even after an external clock failure.

All available clock signals can be output on one of two selectable pins.



Table 10 Ins	truction Set Summary (contra)	
Mnemonic	Description	Bytes
ROL/ROR	Rotate left/right direct word GPR	2
ASHR	Arithmetic (sign bit) shift right direct word GPR	2
MOV(B)	Move word (byte) data	2/4
MOVBS/Z	Move byte operand to word op. with sign/zero extension	2/4
JMPA/I/R	Jump absolute/indirect/relative if condition is met	4
JMPS	Jump absolute to a code segment	4
JB(C)	Jump relative if direct bit is set (and clear bit)	4
JNB(S)	Jump relative if direct bit is not set (and set bit)	4
CALLA/I/R	Call absolute/indirect/relative subroutine if condition is met	4
CALLS	Call absolute subroutine in any code segment	4
PCALL	Push direct word register onto system stack and call absolute subroutine	4
TRAP	Call interrupt service routine via immediate trap number	2
PUSH/POP	Push/pop direct word register onto/from system stack	2
SCXT	Push direct word register onto system stack and update register with word operand	4
RET(P)	Return from intra-segment subroutine (and pop direct word register from system stack)	2
RETS	Return from inter-segment subroutine	2
RETI	Return from interrupt service subroutine	2
SBRK	Software Break	2
SRST	Software Reset	4
IDLE	Enter Idle Mode	4
PWRDN	Unused instruction <sup>1)</sup>	4
SRVWDT	Service Watchdog Timer	4
DISWDT/ENWDT	Disable/Enable Watchdog Timer	4
EINIT	End-of-Initialization Register Lock	4
ATOMIC	Begin ATOMIC sequence	2
EXTR	Begin EXTended Register sequence	2
EXTP(R)	Begin EXTended Page (and Register) sequence	2/4
EXTS(R)	Begin EXTended Segment (and Register) sequence	2/4

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## 4.1.3 Pad Timing Definition

If not otherwise noted, all timing parameters are tested and are valid for the corresponding output pins operating in strong driver, fast edge mode. See also "Pad Properties" on Page 116.

## 4.1.4 Parameter Interpretation

The parameters listed in the following include both the characteristics of the XE167xM and its demands on the system. To aid in correctly interpreting the parameters when evaluating them for a design, they are marked accordingly in the column "Symbol":

**CC** (Controller Characteristics):

The logic of the XE167xM provides signals with the specified characteristics.

#### SR (System Requirement):

The external system must provide signals with the specified characteristics to the XE167xM.



			•	•	•	,
Parameter Symbol Values		Values		Note /		
		Min.	Тур.	Max.		Test Condition
Output Low Voltage <sup>8)</sup>	$V_{\rm OL}{\rm CC}$	-	-	1.0	V	$I_{\rm OL} \leq I_{\rm OLmax}$
		-	-	0.4	V	$I_{\rm OL} \leq I_{\rm OLnom}^{9)}$

#### Table 13 DC Characteristics for Upper Voltage Range (cont'd)

1) Because each double bond pin is connected to two pads (standard pad and high-speed pad), it has twice the normal value. For a list of affected pins refer to the pin definitions table in chapter 2.

- Not subject to production test verified by design/characterization. Hysteresis is implemented to avoid metastable states and switching due to internal ground bounce. It cannot suppress switching due to external system noise under all conditions.
- 3) If the input voltage exceeds the respective supply voltage due to ground bouncing ( $V_{\rm IN} < V_{\rm SS}$ ) or supply ripple ( $V_{\rm IN} > V_{\rm DDP}$ ), a certain amount of current may flow through the protection diodes. This current adds to the leakage current. An additional error current ( $I_{\rm INJ}$ ) will flow if an overload current flows through an adjacent pin. Please refer to the definition of the overload coupling factor  $K_{\rm CV}$ .
- 4) The given values are worst-case values. In production test, this leakage current is only tested at 125 °C; other values are ensured by correlation. For derating, please refer to the following descriptions: Leakage derating depending on temperature (*T*<sub>J</sub> = junction temperature [°C]): *I*<sub>OZ</sub> = 0.05 x e<sup>(1.5 + 0.028 x TJ-)</sup> [µA]. For example, at a temperature of 95 °C the resulting leakage current is 3.2 µA. Leakage derating depending on voltage level (DV = *V*<sub>DDP</sub> *V*<sub>PIN</sub> [V]): *I*<sub>OZ</sub> = *I*<sub>OZtempmax</sub> (1.6 x DV) (µA]. This voltage derating formula is an approximation which applies for maximum temperature.
- 5) Drive the indicated minimum current through this pin to change the default pin level driven by the enabled pull device: V<sub>PIN</sub> ≤ V<sub>ILmax</sub> for a pullup; V<sub>PIN</sub> ≥ V<sub>ILmin</sub> for a pulldown.
- 6) These values apply to the fixed pull-devices in dedicated pins and to the user-selectable pull-devices in general purpose IO pins.
- 7) Limit the current through this pin to the indicated value so that the enabled pull device can keep the default pin level: V<sub>PIN</sub> ≥ V<sub>IHmin</sub> for a pullup; V<sub>PIN</sub> ≤ V<sub>ILmax</sub> for a pulldown.
- 8) The maximum deliverable output current of a port driver depends on the selected output driver mode. This specification is not valid for outputs which are switched to open drain mode. In this case the respective output will float and the voltage is determined by the external circuit.
- 9) As a rule, with decreasing output current the output levels approach the respective supply level ( $V_{OL}$ -> $V_{SS}$ ,  $V_{OH}$ -> $V_{DDP}$ ). However, only the levels for nominal output currents are verified.



## 4.2.3 Power Consumption

The power consumed by the XE167xM depends on several factors such as supply voltage, operating frequency, active circuits, and operating temperature. The power consumption specified here consists of two components:

- The switching current  $I_{\rm S}$  depends on the device activity
- The leakage current I<sub>LK</sub> depends on the device temperature

To determine the actual power consumption, always both components, switching current  $I_{\rm S}$  and leakage current  $I_{\rm LK}$  must be added:

 $I_{\text{DDP}} = I_{\text{S}} + I_{\text{LK}}.$ 

Note: The power consumption values are not subject to production test. They are verified by design/characterization.

To determine the total power consumption for dimensioning the external power supply, also the pad driver currents must be considered.

The given power consumption parameters and their values refer to specific operating conditions:

Active mode:

Regular operation, i.e. peripherals are active, code execution out of Flash.

Stopover mode:

Crystal oscillator and PLL stopped, Flash switched off, clock in domain DMP\_1 stopped.

Note: The maximum values cover the complete specified operating range of all manufactured devices.

The typical values refer to average devices under typical conditions, such as nominal supply voltage, room temperature, application-oriented activity.

After a power reset, the decoupling capacitors for  $V_{\rm DDIM}$  and  $V_{\rm DDI1}$  are charged with the maximum possible current.

For additional information, please refer to Section 5.2, Thermal Considerations.

Note: Operating Conditions apply.

Parameter	Symbol	Values			Unit	Note /
		Min.	Тур.	Max.		Test Condition
Power supply current (active) with all peripherals active and EVVRs on	I <sub>SACT</sub> CC	-	$10 + 0.6 x f_{SYS}^{1)}$	10 + 1.0 x $f_{SYS}^{1)}$	mA	2)3)
Power supply current in stopover mode, EVVRs on	$I_{\rm SSO}$ CC	-	0.7	2.0	mA	

## Table 15 Switching Power Consumption

1)  $f_{\rm SYS}$  in MHz.



2) The pad supply voltage pins (V<sub>DDPB</sub>) provide the input current for the on-chip EVVRs and the current consumed by the pin output drivers. A small current is consumed because the drivers input stages are switched.

In Fast Startup Mode (with the Flash modules deactivated), the typical current is reduced to  $3 + 0.6 \text{ x} f_{SYS}$ .

3) Please consider the additional conditions described in section "Active Mode Power Supply Current".

## Active Mode Power Supply Current

The actual power supply current in active mode not only depends on the system frequency but also on the configuration of the XE167xM's subsystem.

Besides the power consumed by the device logic the power supply pins also provide the current that flows through the pin output drivers.

A small current is consumed because the drivers' input stages are switched.

The IO power domains can be supplied separately. Power domain A ( $V_{\rm DDPA}$ ) supplies the A/D converters and Port 6. Power domain B ( $V_{\rm DDPB}$ ) supplies the on-chip EVVRs and all other ports.

During operation domain A draws a maximum current of 1.5 mA for each active A/D converter module from  $V_{\rm DDPA}$ .

In Fast Startup Mode (with the Flash modules deactivated), the typical current is reduced to  $(3 + 0.6 \times f_{SYS})$  mA.



#### **Electrical Parameters**



Figure 15 Leakage Supply Current as a Function of Temperature



- 3)  $f_{\rm WU}$  in MHz
- 4) This value includes a hysteresis of approximately 50 mV for rising voltage.
- 5)  $V_{\rm LV}$  = selected SWD voltage level
- 6) The limit  $V_{LV}$  0.10 V is valid for the OK1 level. The limit for the OK2 level is  $V_{LV}$  0.15 V.

## Conditions for t<sub>SPO</sub> Timing Measurement

The time required for the transition from **Power-On** to **Base** mode is called  $t_{SPO}$ . It is measured under the following conditions:

Precondition: The pad supply is valid, i.e.  $V_{\text{DDPB}}$  is above 3.0 V and remains above 3.0 V even though the XE167xM is starting up. No debugger is attached.

Start condition: Power-on reset is removed ( $\overline{PORST} = 1$ ).

End condition: External pin toggle caused by first user instruction executed from FLASH after startup.

## Conditions for t<sub>SSO</sub> Timing Measurement

The time required for the transition from **Stopover** to **Stopover Waked-Up** mode is called  $t_{SSO}$ . It is measured under the following conditions:

Precondition: The **Stopover** mode has been entered using the procedure defined in the Programmer's Guide.

Start condition: Pin toggle on ESR pin triggering the startup sequence.

Coding of bit fields LEVxV in SWD and PVC Configuration Registers

End condition: External pin toggle caused by first user instruction executed from PSRAM after startup.

Table 20	County of bit news LEVAV in Register SWDCOND						
Code	Default Voltage Level	Notes <sup>1)</sup>					
0000 <sub>B</sub>	2.9 V						
0001 <sub>B</sub>	3.0 V	LEV1V: reset request					
0010 <sub>B</sub>	3.1 V						
0011 <sub>B</sub>	3.2 V						
0100 <sub>B</sub>	3.3 V						
0101 <sub>B</sub>	3.4 V						
0110 <sub>B</sub>	3.6 V						
0111 <sub>B</sub>	4.0 V						
1000 <sub>B</sub>	4.2 V						

## Table 20 Coding of bit fields LEVxV in Register SWDCON0



Table 22	Flash Parameters	(cont'd)
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Parameter	Symbol		Values		Unit	Note / Test Condition
		Min.	Тур.	Max.		
Number of erase cycles	N <sub>Er</sub> SR	-	-	15 000	cycle s	$t_{RET} \ge 5$ years; Valid for up to 64 user- selected sectors (data storage)
		_	_	1 000	cycle s	$t_{RET} \ge 20$ years

 All Flash module(s) can be erased/programmed while code is executed and/or data is read from only one Flash module or from PSRAM. The Flash module that delivers code/data can, of course, not be erased/programmed.

 Flash module 3 can be erased/programmed while code is executed and/or data is read from any other Flash module.

3) Value of IMB\_IMBCTRL.WSFLASH.

4) Programming and erase times depend on the internal Flash clock source. The control state machine needs a few system clock cycles. This increases the stated durations noticably only at extremely low system clock frequencies.

Access to the XE167xM Flash modules is controlled by the IMB. Built-in prefetch mechanisms optimize the performance for sequential access.

Flash access waitstates only affect non-sequential access. Due to prefetch mechanisms, the performance for sequential access (depending on the software structure) is only partially influenced by waitstates.



- 1) The amplitude voltage  $V_{AX1}$  refers to the offset voltage  $V_{OFF}$ . This offset voltage must be stable during the operation and the resulting voltage peaks must remain within the limits defined by  $V_{IX1}$ .
- 2) Overload conditions must not occur on pin XTAL1.
- Note: For crystal or ceramic resonator operation, it is strongly recommended to measure the oscillation allowance (negative resistance) in the final target system (layout) to determine the optimum parameters for oscillator operation.

The manufacturers of crystals and ceramic resonators offer an oscillator evaluation service. This evaluation checks the crystal/resonator specification limits to ensure a reliable oscillator operation.



Figure 21 External Clock Drive XTAL1



## Debug via JTAG

The following parameters are applicable for communication through the JTAG debug interface. The JTAG module is fully compliant with IEEE1149.1-2000.

Note: These parameters are not subject to production test but verified by design and/or characterization.

Note: Operating Conditions apply;  $C_L$ = 20 pF.

Parameter	Symbol	Values			Unit	Note /
		Min.	Тур.	Max.		Test Condition
TCK clock period	t <sub>1</sub> SR	50 <sup>1)</sup>	-	-	ns	2)
TCK high time	$t_2$ SR	16	-	-	ns	
TCK low time	t <sub>3</sub> SR	16	-	-	ns	
TCK clock rise time	$t_4$ SR	-	-	8	ns	
TCK clock fall time	t <sub>5</sub> SR	-	-	8	ns	
TDI/TMS setup to TCK rising edge	t <sub>6</sub> SR	6	-	-	ns	
TDI/TMS hold after TCK rising edge	t <sub>7</sub> SR	6	-	-	ns	
TDO valid from TCK falling edge (propagation delay) <sup>3)</sup>	t <sub>8</sub> CC	-	25	29	ns	
TDO high impedance to valid output from TCK falling edge <sup>4)3)</sup>	t <sub>9</sub> CC	-	25	29	ns	
TDO valid output to high impedance from TCK falling edge <sup>3)</sup>	<i>t</i> <sub>10</sub> CC	-	25	29	ns	
TDO hold after TCK falling edge <sup>3)</sup>	<i>t</i> <sub>18</sub> CC	5	_	_	ns	

#### Table 39JTAG Interface Timing for Upper Voltage Range

1) The debug interface cannot operate faster than the overall system, therefore  $t_1 \ge t_{SYS}$ .

2) Under typical conditions, the interface can operate at transfer rates up to 20 MHz.

3) The falling edge on TCK is used to generate the TDO timing.

4) The setup time for TDO is given implicitly by the TCK cycle time.